



Attorney Docket No.: 020921-000710US PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of:

VICTOR B. KLEY

Application No.: 10/019,009

Filed: April 26, 2002

For: OBJECT INSPECTION AND/OR  
MODIFICATION SYSTEM AND  
METHOD

Customer No.: 20350

Confirmation No.: 2617

Examiner: K. NGUYEN

Art Unit: 2881

**RESPONSE TO RESTRICTION  
REQUIREMENT**

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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In response to the Office Action mailed June 10, 2003, Applicant elects, without traverse, to prosecute the claims in Group I (Claims 1-2, 4, 6, 8-11, 14-16, 18, 20-23, 26-27, 29, 31 and 33-36, drawn to a method using a probe for measuring a sample in a scanning probe microscope, classified in class 250, subclass 307).

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper.

**Remarks/Arguments** begin on page 10 of this paper.